

Search Notes

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10/517,744

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

MAASS ET AL.

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	436	3/13/2007	JAT
	435	3/13/2007	JAT
	437	3/13/2007	JAT
	937	3/13/2007	JAT
180	280	3/13/2007	JAT
	274	3/13/2007	JAT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR